

Adversarial Environment Design via Regret-Guided Diffusion Models

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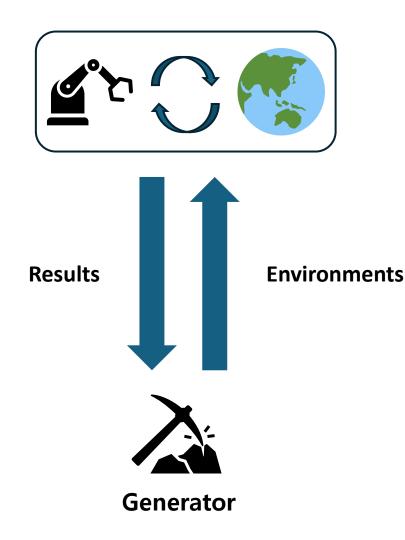
Problem Definition

- Autonomous agents often fail in unseen environments.
- To train an agent robust to environmental changes, we focus on generating adversarial environments in which the agent will be trained.





Unsupervised Environment Design (UED)



• UED is a framework designed to find a minimax regret policy π^* that is robust to the variations in the environment θ .

 $\pi^* \in \operatorname*{argmin}_{\pi \in \Pi} \max_{\theta \in \Theta} \operatorname{Regret}(\pi, \theta)$

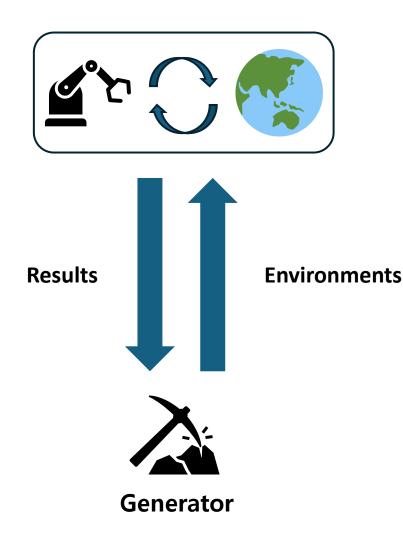
$$\operatorname{Regret}(\pi,\theta) := -V(\pi,\theta) + \max_{\pi' \in \Pi} V(\pi',\theta)$$

• To obtain π^* , UED solves the following min-max problem:

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\min_{\pi \in \Pi} \max_{\theta \in \Theta} \operatorname{Regret}(\pi, \theta)
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Unsupervised Environment Design (UED)



- Prior works on UED
 - train an environment generator via reinforcement learning.
 - Stability ↓ / Sample efficiency ↑
 - replay among randomly generated environments with high regrets.
 - Stability † / Sample efficiency ↓
- We propose a method which takes the advantages of two approaches by **leveraging the power of the diffusion model**.

Soft UED

• We augment the UED objective to ensure the diversity of the training environments and enhance the stability.

$$\min_{\pi \in \Pi} \max_{\Lambda \in \mathcal{D}_{\Lambda}} \mathop{\mathbb{E}}_{\theta \sim \Lambda} \left[\operatorname{Regret}(\pi, \theta) \right] + \frac{1}{\omega} H(\Lambda)$$

A: distribution over a set of environment parameter

• The modified min-max problem has a valid optimal point.

Proposition 4.1. Let $L(\pi, \Lambda) := \mathbb{E}_{\theta \sim \Lambda} [\operatorname{REGRET}(\pi, \theta)] + \frac{1}{\omega} H(\Lambda)$ and assume that $S, A, and \Theta$ are finite. Then, $\min_{\pi \in \Pi} \max_{\Lambda \in \mathcal{D}_{\Lambda}} L(\pi, \Lambda) = \max_{\Lambda \in \mathcal{D}_{\Lambda}} \min_{\pi \in \Pi} L(\pi, \Lambda)$.







Regret-Guided Diffusion Models

• The soft UED converts the problem of finding regret-maximizing θ into the problem of sampling θ from the following distribution:

$$\Lambda^{\pi}(\theta) = \frac{u(\theta) \exp(\omega \text{REGRET}(\pi, \theta))}{C^{\pi}}$$

 $u(\cdot)$: uniform distribution

- C^{π} : normalizing constant
- ω : guidance weight

• Then, we solve this sampling problem using guided diffusion:

: pre-train a diffusion model,

 $\nabla_{\theta_t} \log \Lambda_t^{\pi}(\theta_t) = \nabla_{\theta_t} \log u_t(\theta_t) + \omega \nabla_{\theta_t} \operatorname{REGRET}_t(\pi, \theta_t)$

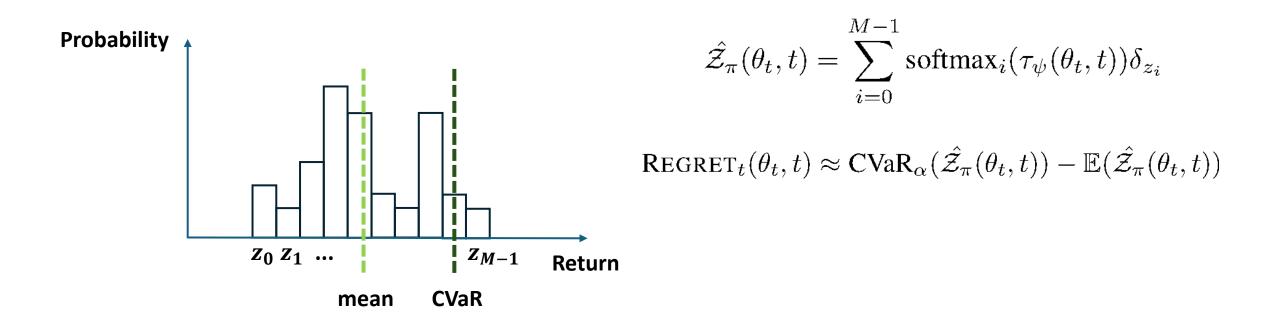
$$s_{\phi}^{\pi}(\theta_{t}, t) = s_{\phi}(\theta_{t}, t) + \omega \nabla_{\theta_{t}} \operatorname{REGRET}_{t}(\pi, \theta_{t}),$$
$$d\theta_{t} = -\beta_{t} \left[\frac{1}{2} \theta_{t} + s_{\phi}^{\pi}(\theta_{t}, t) \right] dt + \sqrt{\beta_{t}} dW_{t}.$$

: estimate regret in a differentiable form



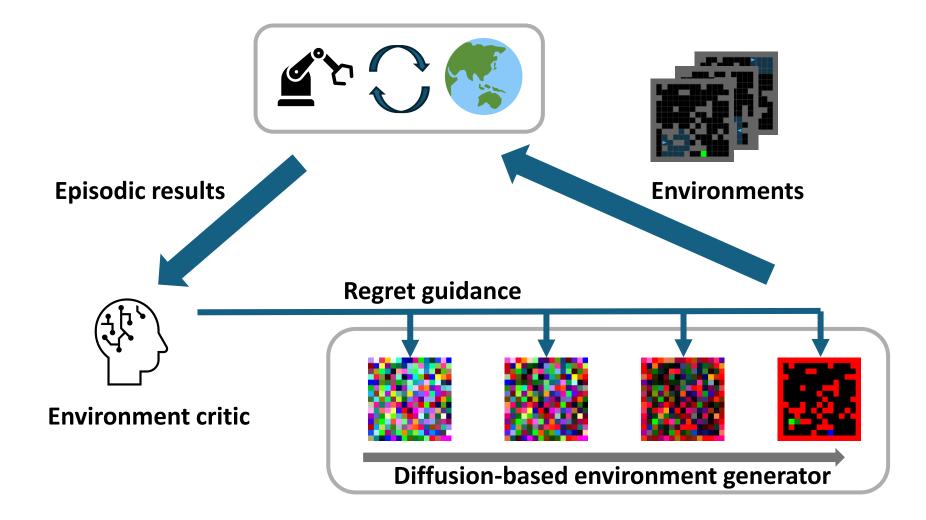
A Differentiable Regret Estimator

- Prior works estimate the regret in a non-differentiable form.
- We utilize an environment critic τ_{ψ} , which predicts a distribution of return.



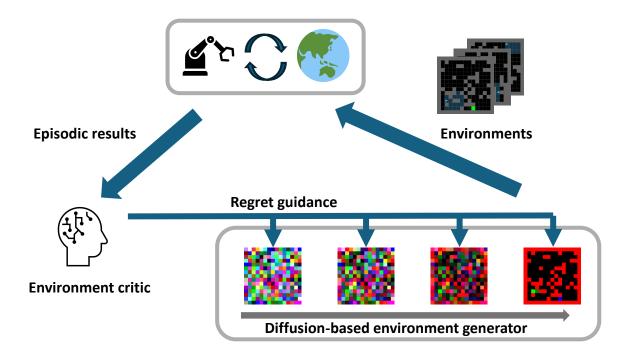


Overview: ADD





Overview: ADD

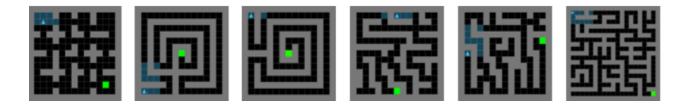


- No additional training of the generator
 Stability ↑
- Directly generates training environments
 Sample efficiency [↑]
- Effectively combines the strengths of previous UED methods!



Experiments

- Tasks
 - Minigrid



BipedalWalker



- Evaluation
 - Zero-shot transfer performance
 - Generated curriculum



Minigrid Results

Test environments

SixteenRooms2







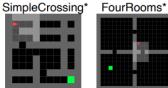
Maze

LargeCorridor*

Maze2







SmallCorridor*



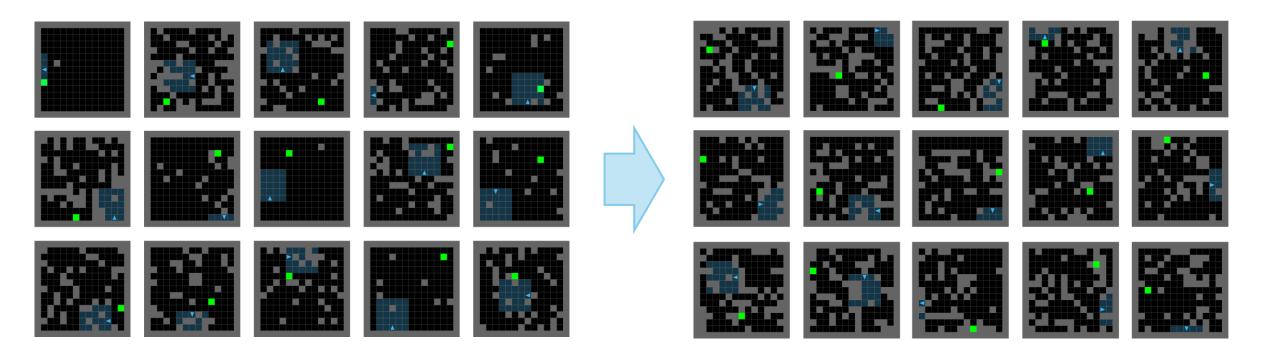
(b) Training curves (c) Complexity metrics (d) t-SNE plots (a) Zero-shot performance Mean solved rate Labyrinth Number of blocks ADD 1e8 1.0 1.00 50 40 30 - 2.0 0.8 40 0.75 20 Solved rate 9.0 rate 1.5 Steps 10 Blocks 20 Solved 1 0 -10 0.25 -20 - 0.5 0.2 10 -30 0.00 | 0.0 -40 0.0 - 0.0 0.0 0.5 1.0 1.5 2.0 2.5 1e8 1.0 1.5 2.0 2.5 le8 0.5 -40 -20 20 40 0 Box plot of solved rate Maze Shortest path length PAIRED 1e8 1.0 1.00 40 50 30 0.8 - 2.0 0.75 20 40 Solved rate rate 1.5 Steps 10 Blocks 0.50 0 -10 20 0.25 -20 - 0.5 0.2 10 -30 0.00 0.0 0.0 0.0 0.5 -40 1.0 1.5 1.0 1.5 0.5 2.0 2.5 2.0 2.5 -20 -40 0 20 40 1e8 1e8 Steps Steps **PLR**[⊥] ACCEL ADD w/o guidance DR PAIRED - ADD (ours)

Results



Minigrid Results

Generated training environments

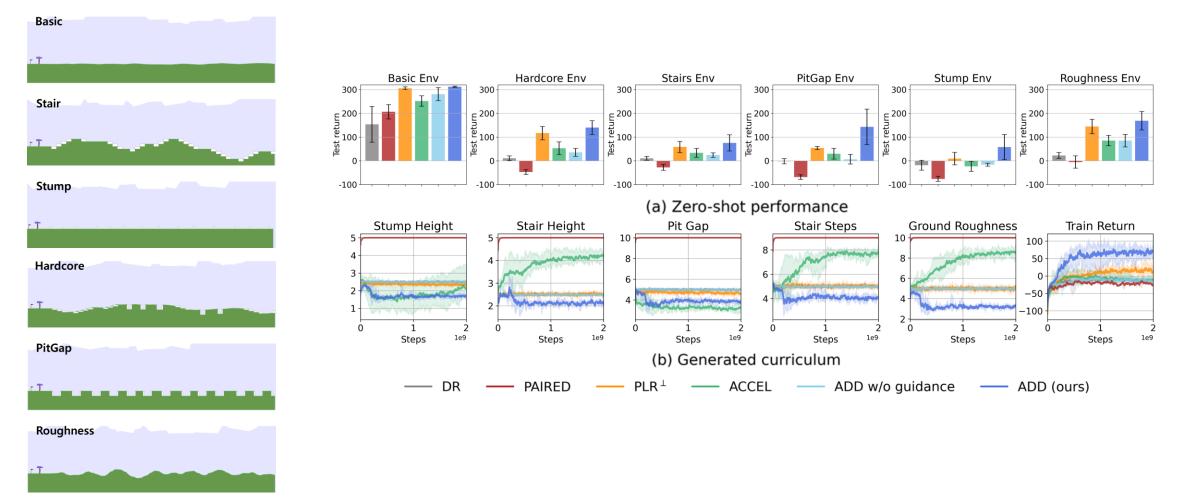




BipedalWalker Results

Test environments

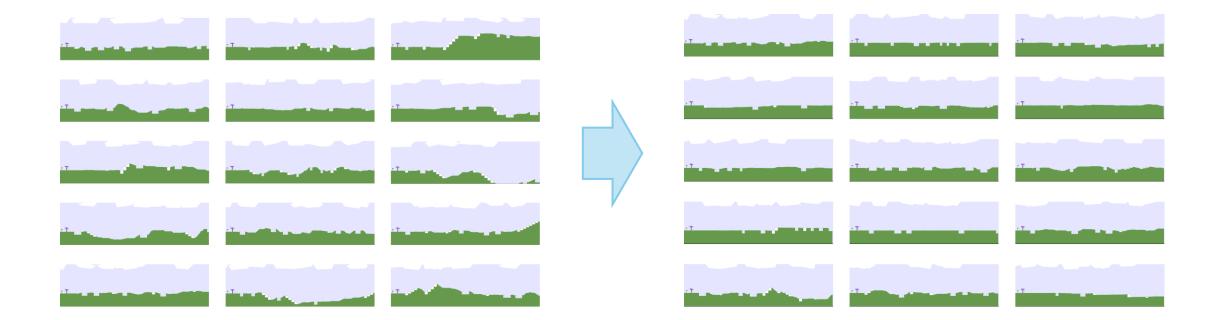
Results





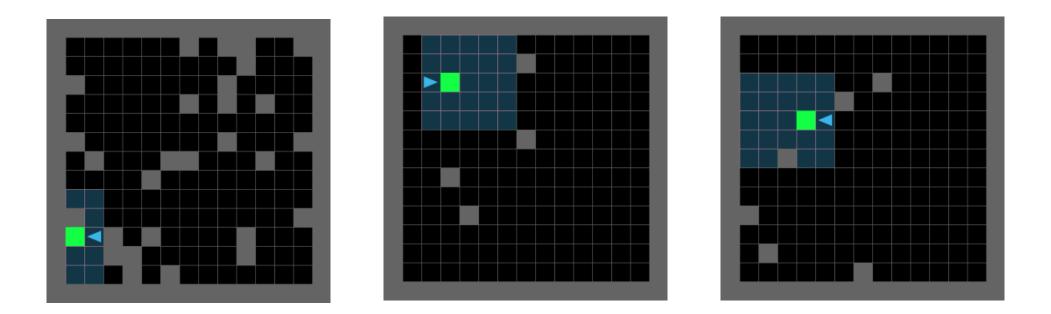
BipedalWalker Results

Generated training environments





Controlling Difficulty Levels

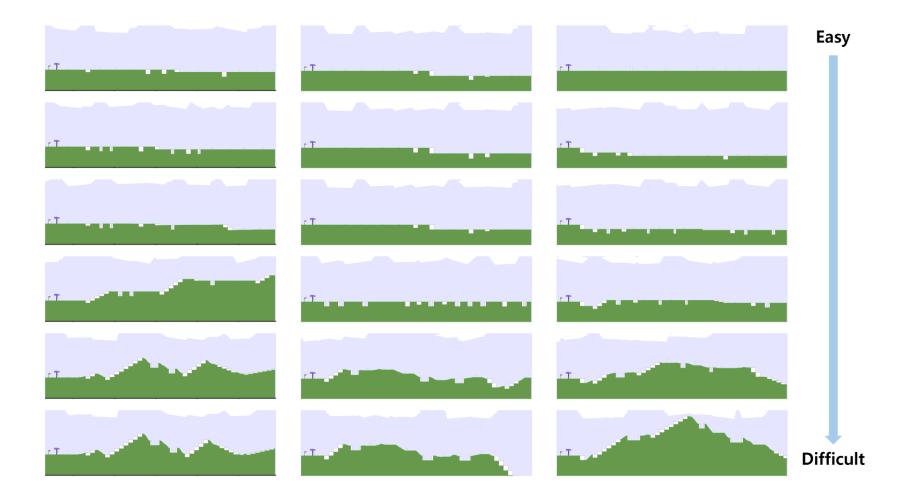


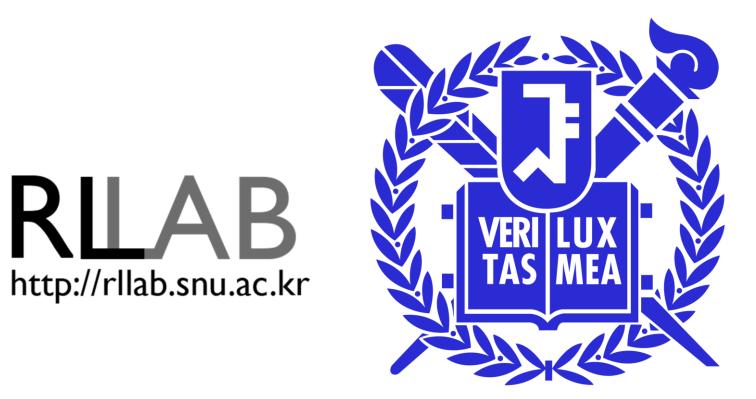
• Additionally, our method can control the difficulty level of environments it generates

$$s_{\phi}'(\theta_t, t) = s_{\phi}(\theta_t, t) + \omega \nabla_{\theta_t} \log \Pr(\hat{\mathcal{Z}}_{\pi}(\theta_t, t) = z_{M-k}),$$
$$d\theta_t = -\beta_t \left[\frac{1}{2}\theta_t + s_{\phi}'(\theta_t, t)\right] dt + \sqrt{\beta_t} dW_t.$$



Controlling Difficulty Levels





Thank you for your attention

If you have any questions, please contact hojun.chung@rllab.snu.ac.kr